

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/773,371	<b>Applicant(s)/Patent under Reexamination</b> OHBAYASHI ET AL.
	<b>Examiner</b> Frederick J. Parker	<b>Art Unit</b> 1762

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner